imall

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

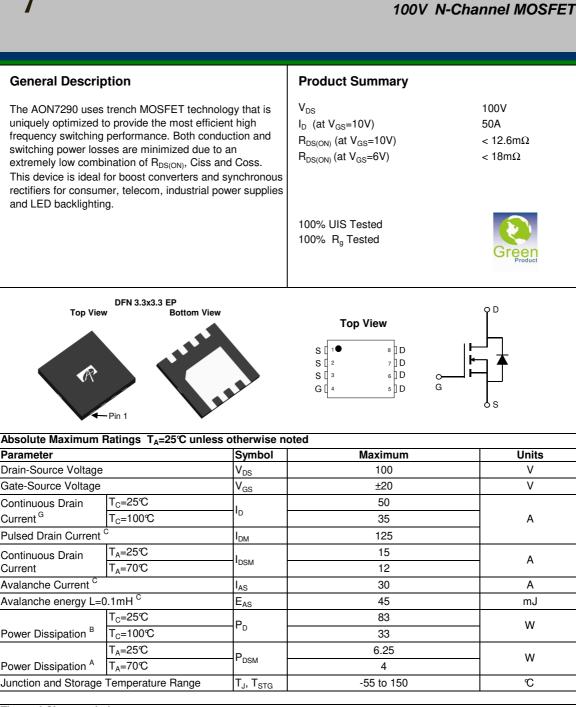
We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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ALPHA & OMEGA SEMICONDUCTOR

Thermal Characteristics									
Parameter		Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient ^A	t ≤ 10s	$R_{ extsf{ heta}JA}$	16	20	℃/W				
Maximum Junction-to-Ambient AD	Steady-State		45	55	℃/W				
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	1	1.5	°C/W				

AON7290

Units

V V

А

А

А

mJ

W

W

C



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	arameter Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D=250\mu A, V_{GS}=0V$		100			V
I _{DSS} Zero Gate Voltage	Zaro Cata Valtaga Drain Current	V _{DS} =100V, V _{GS} =0V				1	μA
	Zero Gale Vollage Drain Current					5	
I _{GSS}	Gate-Body leakage current	$V_{DS}=0V, V_{GS}=\pm 20V$				±100	nA
V _{GS(th)}	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$		2.2	2.85	3.4	V
I _{D(ON)}	On state drain current	V_{GS} =10V, V_{DS} =5V		125			Α
R _{DS(ON)}		V_{GS} =10V, I_{D} =15A			10.5	12.6	mΩ
	Static Drain-Source On-Resistance		T _J =125℃		19.7	23.8	
		V _{GS} =6V, I _D =12A			13.5	18	mΩ
g fs	Forward Transconductance	$V_{DS}=5V, I_{D}=15A$			28		S
V _{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.7	1	V
I _S	Maximum Body-Diode Continuous Current G					55	Α
DYNAMIC	C PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =50V, f=1MHz			2075		pF
C _{oss}	Output Capacitance				175		pF
C _{rss}	Reverse Transfer Capacitance				9.5		pF
R _g	Gate resistance	$V_{GS}=0V, V_{DS}=0V, f=1MHz$		0.7	1.4	2.1	Ω
SWITCHI	NG PARAMETERS						
Q _g (10V)	Total Gate Charge				26.5	38	nC
Q _g (4.5V)	Total Gate Charge	V10V. V50V	1_15A		9	15	nC
Q _{gs}	Gate Source Charge	V _{GS} =10V, V _{DS} =50V, I _D =15A			8.5		nC
Q _{gd}	Gate Drain Charge				4		nC
t _{D(on)}	Turn-On DelayTime	V_{GS} =10V, V_{DS} =50V, R_{L} =3.3 Ω , R_{GEN} =3 Ω			10		ns
t _r	Turn-On Rise Time				3.5		ns
t _{D(off)}	Turn-Off DelayTime				22.5		ns
t _f	Turn-Off Fall Time				3		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =15A, dI/dt=500A/μs			35		ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =15A, dI/dt=500A/μs			185		nC

A. The value of R_{6JA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R _{eJA} t \leq 10s value and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 150° C may be used if the PCB allows it.

B. The power dissipation P_D is based on $T_{J(MAX)}=150^{\circ}$ C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C. Ratings are based on low frequency and duty cycles to keep initial $T_{J} = 25^{\circ}$ C.

D. The $R_{\rm 6JA}$ is the sum of the thermal impedance from junction to case $R_{\rm 6JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 µs pulses, duty cycle 0.5% max. F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150° C. The SOA curve provides a single pulse rating.

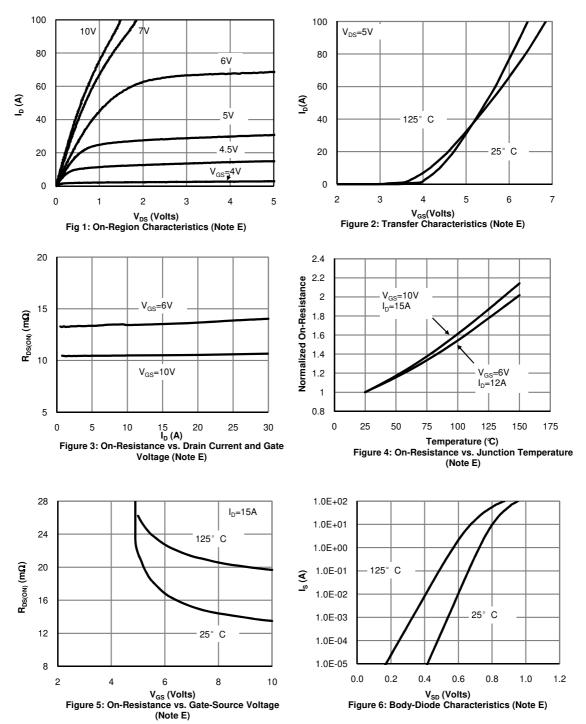
G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.

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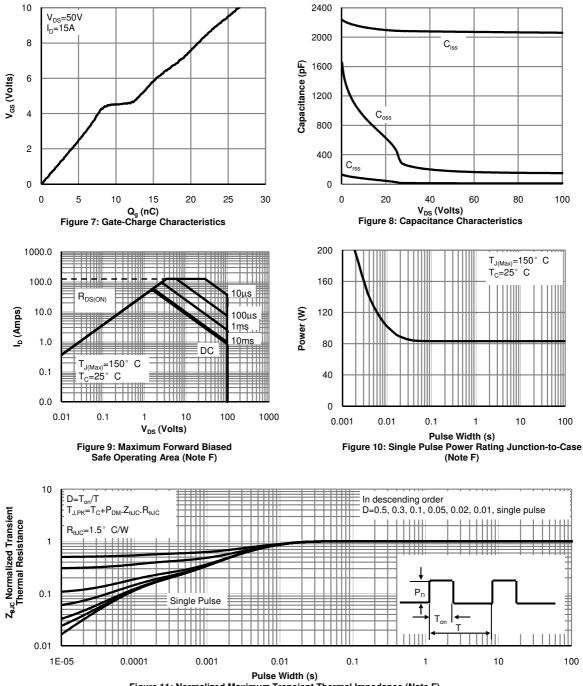


TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





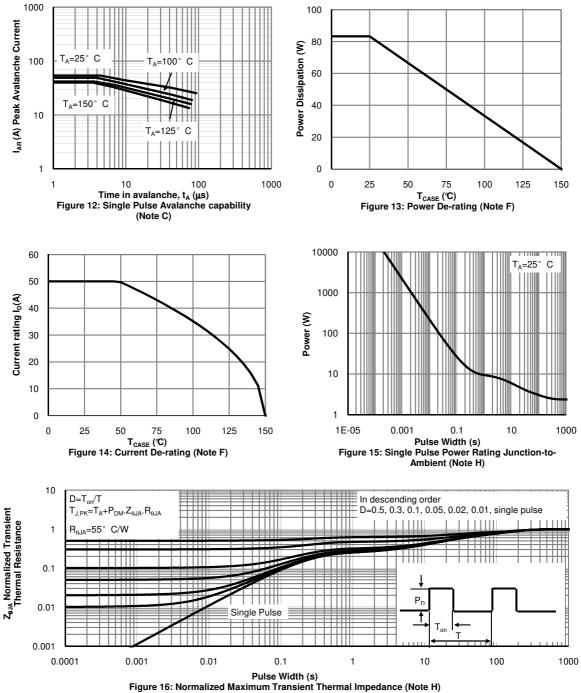
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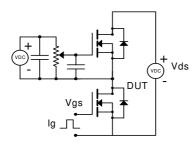


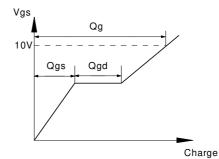
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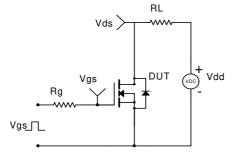


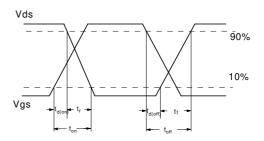
Gate Charge Test Circuit & Waveform



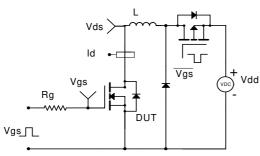


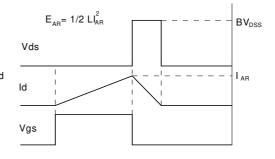
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

